CLAIMS

1. A modulation quality detection system for determining the modulation quality of an illumination modulator in an imaging system, said modulation quality detection system comprising:

modulator adjustment means for providing a test pattern on the illumination modulator;

a detector for receiving a modulated illumination field from said illumination modulator;

sampling means for determining at least three sample values (A, B and C) for each of three areas of said modulated illumination field respectively; and

evaluation means for determining whether the value $\left(\frac{A+C}{2}\right)-B$ is greater than a threshold value.

- 2. The modulation quality detection system as claimed in claim 1, wherein said sample values A and C are for areas that are within about 20% of each end of the modulated illumination field.
- 3. The modulation quality detection system as claimed in claim 1, wherein said imaging system provides zero order imaging.
- 4. The modulation quality detection system as claimed in claim 1, wherein each of said sample values (A, B and C) is provided by an average of about 100 sample values.

- 5. The modulation quality detection system as claimed in claim 1, wherein said illumination modulator includes a grating light valve and said test pattern on said illumination modulator provides two shutters on at each end of the illumination modulator.
- 6. A modulation quality detection system for determining the modulation quality of an illumination modulator in an imaging system, said modulation quality detection system comprising:

modulator adjustment means for providing a test pattern on the illumination modulator;

a detector for receiving a modulated illumination field from said illumination modulator;

sampling means for determining at least three sample values (A, B and C) for each of first, second and third areas of said modulated illumination field respectively wherein said first and third areas are each within about 20% of an end of said modulated illumination field; and

evaluation means for determining whether a quality of said modulated illumination field is within a defined standard.

7. The modulation quality detection system as claimed in claim 7, wherein said first and third areas that are within about 15% of each end of the modulated illumination field.

- 8. The modulation quality detection system as claimed in claim 7, wherein said imaging system provides zero order imaging.
- 9. The modulation quality detection system as claimed in claim 7, wherein each of said sample values (A, B and C) is provided by an average of about 100 sample values.
- 10. The modulation quality detection system as claimed in claim 7, wherein said illumination modulator includes a grating light valve and said test pattern on said illumination modulator provides two shutters on at each end of the illumination modulator.
- 11. A method of determining the modulation quality of an illumination modulator in an imaging system, said method comprising the steps of:

providing a test pattern on the illumination modulator;

receiving a modulated illumination field from said illumination modulator;

determining at least three sample values (A, B and C) for each of three areas of said modulated illumination field respectively; and

determining whether the value $\left(\frac{A+C}{2}\right)-B$ is greater than a threshold value.

12. The method as claimed in claim 11, wherein said sample values A and C are for areas that are within about 20% of each end of the modulated illumination field

- 13. The method as claimed in claim 11, wherein said imaging system provides zero order imaging.
- 14. The method as claimed in claim 11, wherein each of said sample values (A, B and C) is provided by an average of about 100 sample values.
- 15. The method as claimed in claim 11, wherein said illumination modulator includes a grating light valve and said test pattern on said illumination modulator provides two shutters on at each end of the illumination modulator.